

TC74AC175P, TC74AC175F, TC74AC175FN, TC74AC175FT**QUAD D-TYPE FLIP FLOP WITH CLEAR**

(Note) The JEDEC SOP (FN) is not available in Japan.

The TC74AC175 is an advanced high speed CMOS QUAD D-TYPE FLIP FLOP fabricated with silicon gate and double-layer metal wiring C2MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

These four flip-flops are controlled by a clock input (CK) and a clear input (CLR).

The information data applied to the D inputs (D1 thru D4) are transferred to the outputs (Q1 thru Q4 and \bar{Q}_1 thru \bar{Q}_4) on the positive-going edge of the clock pulse.

Reset function is accomplished when the clear input is taken low, and all Q outputs are kept in low level regardless of other input conditions.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

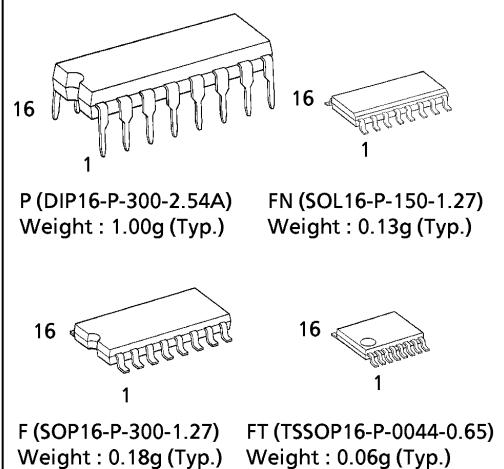
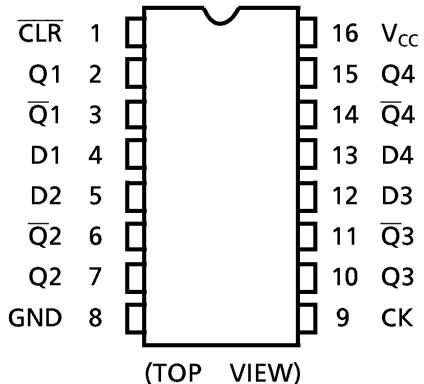
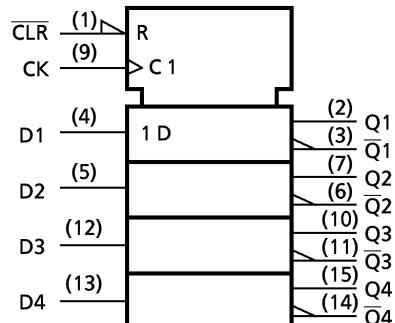
FEATURES:

- High Speed..... $f_{MAX} = 170\text{MHz}$ (typ.) at $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 8\mu\text{A}$ (Max.) at $T_a = 25^\circ\text{C}$
- High Noise Immunity..... $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (Min.)
- Symmetrical Output Impedance....| I_{OH} | = $I_{OL} = 24\text{mA}$ (Min.) Capability of driving 50Ω transmission lines.
- Balanced Propagation Delays..... $t_{pLH} \approx t_{pHL}$
- Wide Operating Voltage Range..... V_{CC} (opr) = $2\text{V} \sim 5.5\text{V}$
- Pin and Function Compatible with 74F175

TRUTH TABLE

INPUTS			OUTPUTS		FUNCTION
CLR	D	CK	Q	\bar{Q}	
L	X	X	L	H	CLEAR
H	L	↑	L	H	—
H	H	↑	H	L	—
H	X	↓	Q_n	\bar{Q}_n	NO CHANGE

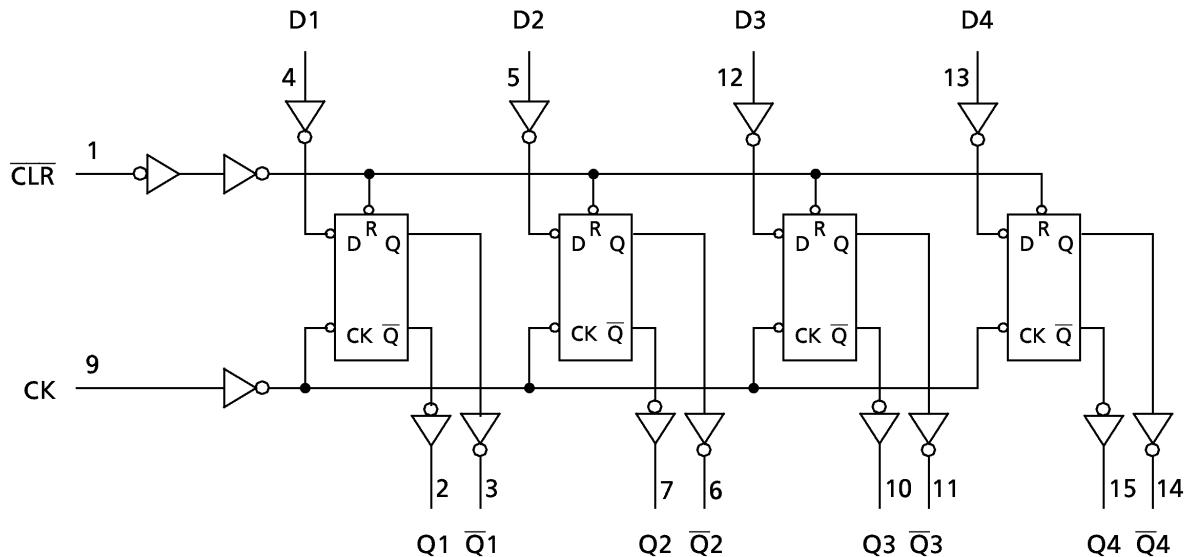
X : Don't Care

**PIN ASSIGNMENT****IEC LOGIC SYMBOL**

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SYSTEM DIAGRAM



ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V_{CC}	-0.5~7.0	V
DC Input Voltage	V_{IN}	-0.5~ $V_{CC} + 0.5$	V
DC Output Voltage	V_{OUT}	-0.5~ $V_{CC} + 0.5$	V
Input Diode Current	I_{IK}	± 20	mA
Output Diode Current	I_{OK}	± 50	mA
DC Output Current	I_{OUT}	± 50	mA
DC V_{CC} /Ground Current	I_{CC}	± 200	mA
Power Dissipation	P_D	500 (DIP)*/ 180 (SOP/TSSOP)	mW
Storage Temperature	T_{stg}	-65~150	°C

*500mW in the range of $T_a = -40^{\circ}\text{C} \sim 65^{\circ}\text{C}$. From $T_a = 65^{\circ}\text{C}$ to 85°C a derating factor of $-10\text{mW}/^{\circ}\text{C}$ should be applied up to 300mW.

RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V_{CC}	2.0~5.5	V
Input Voltage	V_{IN}	0~ V_{CC}	V
Output Voltage	V_{OUT}	0~ V_{CC}	V
Operating Temperature	T_{opr}	-40~85	°C
Input Rise and Fall Time	dt/dV	0~ 100 ($V_{CC} = 3.3 \pm 0.3\text{V}$) 0~ 20 ($V_{CC} = 5 \pm 0.5\text{V}$)	ns / V

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DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION	V_{CC} (V)	Ta = 25°C			Ta = -40~85°C		UNIT	
				MIN.	TYP.	MAX.	MIN.	MAX.		
High - Level Input Voltage	V_{IH}		2.0 3.0 5.5	1.50 2.10 3.85	— — —	— — —	1.50 2.10 3.85	— — —	V	
Low - Level Input Voltage	V_{IL}		2.0 3.0 5.5	— — —	— — —	0.50 0.90 1.65	— — —	0.50 0.90 1.65	V	
High - Level Output Voltage	V_{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -50\mu A$ $I_{OH} = -4mA$ $I_{OH} = -24mA$ $I_{OH} = -75mA^*$	2.0 3.0 4.5 3.0 4.5 5.5	1.9 2.9 4.4 2.58 3.94 —	2.0 3.0 4.5 — — —	— — — 2.48 3.80 3.85	— — — — — —	V	
Low - Level Output Voltage	V_{OL}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OL} = 50\mu A$ $I_{OL} = 12mA$ $I_{OL} = 24mA$ $I_{OL} = 75mA^*$	2.0 3.0 4.5 3.0 4.5 5.5	— — — — — —	0.0 0.0 0.0 — — —	0.1 0.1 0.1 0.36 0.36 —	— — — — — —	V	
Input Leakage Current	I_{IN}	$V_{IN} = V_{CC}$ or GND		5.5	—	—	± 0.1	—	± 1.0	μA
Quiescent Supply Current	I_{CC}	$V_{IN} = V_{CC}$ or GND		5.5	—	—	8.0	—	80.0	

* : This spec indicates the capability of driving 50Ω transmission lines.

One output should be tested at a time for a 10ms maximum duration.

TIMING REQUIREMENTS (Input $t_r = t_f = 3ns$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C		Ta = -40~85°C		UNIT
			V_{CC} (V)	LIMIT	LIMIT	LIMIT	
Minimum Pulse Width (CK)	$t_W(L)$ $t_W(H)$		3.3 ± 0.3	7.0	7.0	5.0	ns
Minimum Pulse Width (CLR)	$t_W(L)$		5.0 ± 0.5	5.0	5.0	5.0	
Minimum Set - up Time	t_s		3.3 ± 0.3	12.0	12.0	6.5	ns
Minimum Hold Time	t_h		5.0 ± 0.5	0.0	0.0	0.0	
Minimum Removal Time (CLR)	t_{rem}		3.3 ± 0.3	7.0	7.0	5.0	
			5.0 ± 0.5	5.0	5.0	5.0	

AC ELECTRICAL CHARACTERISTICS ($C_L = 50\text{pF}$, $R_L = 500\Omega$, Input $t_r = t_f = 3\text{ns}$)

PARAMETER	SYMBOL	TEST CONDITION	Ta = 25°C			Ta = - 40~85°C		UNIT
			V _{CC} (V)	MIN.	TYP.	MAX.	MIN.	
Propagation Delay Time (CK-Q, \bar{Q})	t_{PLH} t_{PHL}		3.3 ± 0.3	—	8.2	13.9	1.0	16.0
			5.0 ± 0.5	—	6.1	8.7	1.0	10.0
Propagation Delay Time (CLR-Q, \bar{Q})	t_{PLH} t_{PHL}		3.3 ± 0.3	—	7.8	13.3	1.0	15.3
			5.0 ± 0.5	—	6.1	8.7	1.0	10.0
Maximum Clock Frequency	f_{MAX}		3.3 ± 0.3	40	80	—	40	—
			5.0 ± 0.5	80	150	—	80	—
Input Capacitance	C_{IN}			—	5	10	—	10
Power Dissipation Capacitance	$C_{PD}(1)$			—	85	—	—	—

Note(1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation :

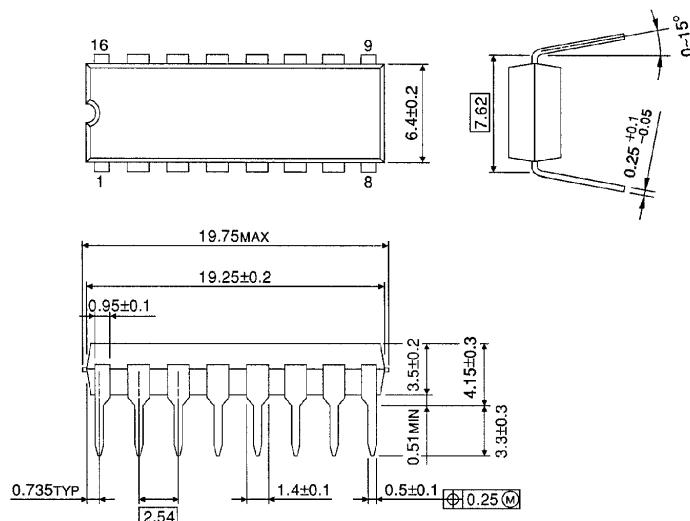
$$I_{CC}(\text{opr.}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 \text{ (per F/F)}$$

And the total C_{PD} when n pcs of Flip Flop operate can be gained by the following equation:

$$C_{PD}(\text{total}) = 35 + 50 \cdot n$$

DIP 16PIN OUTLINE DRAWING (DIP16-P-300-2.54A)

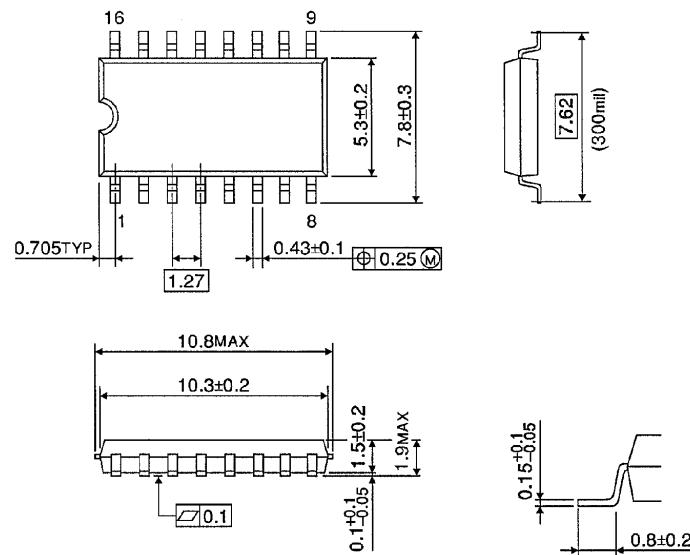
Unit in mm



Weight : 1.00g (Typ.)

SOP 16PIN (200mil BODY) OUTLINE DRAWING (SOP16-P-300-1.27)

Unit in mm

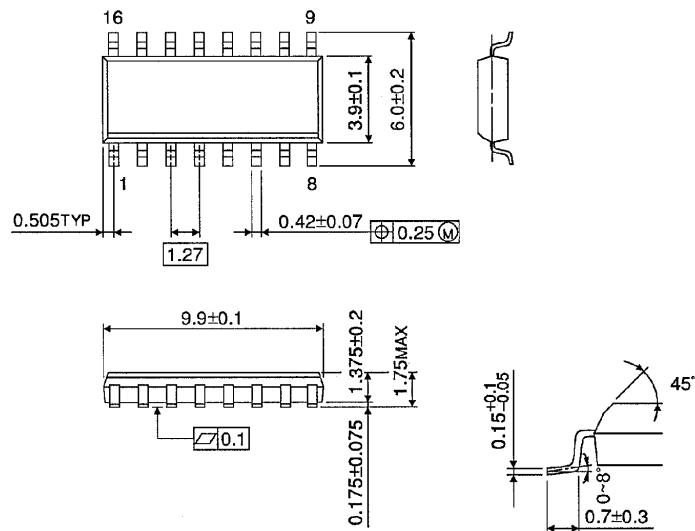


Weight : 0.18g (Typ.)

SOP 16PIN (150mil BODY) OUTLINE DRAWING (SOL16-P-150 -1.27)

Unit in mm

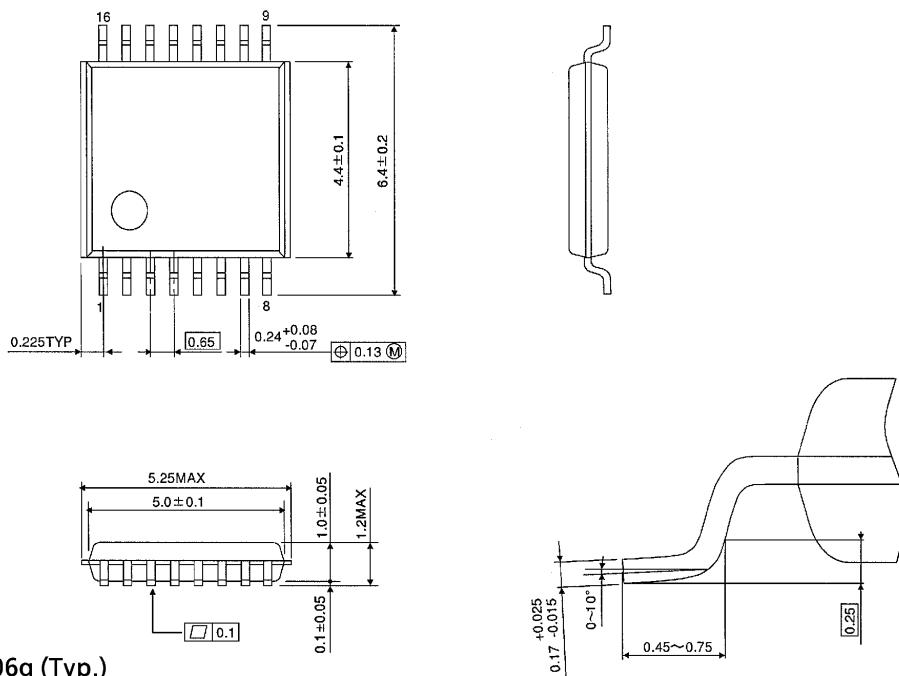
(Note) This package is not available in Japan.



Weight : 0.13g (Typ.)

TSSOP 16PIN OUTLINE DRAWING (TSSOP16-P-0044-0.65)

Unit in mm



Weight : 0.06g (Typ.)